

CY7C375

Selection Guide

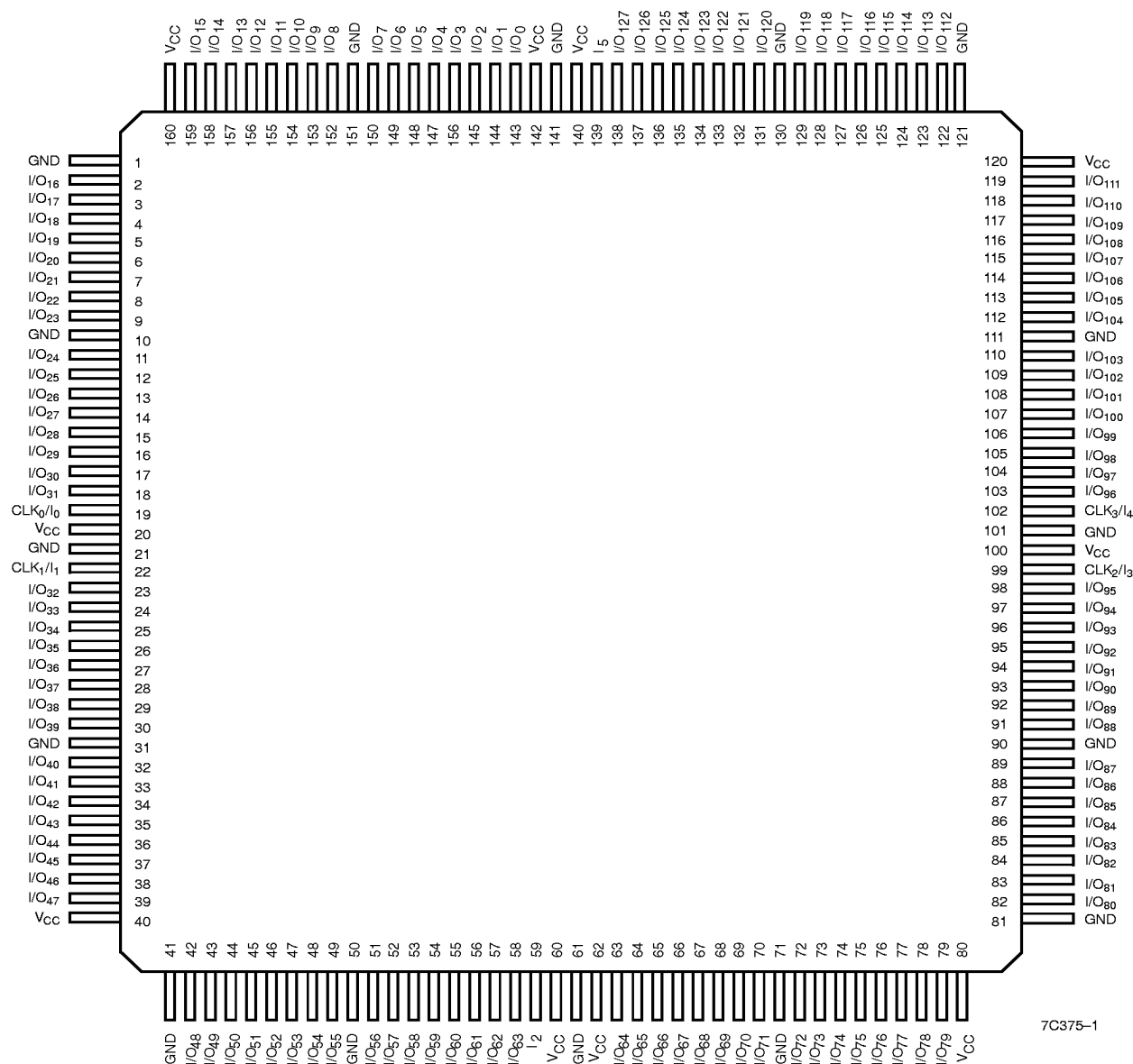
		7C375-100	7C375-83	7C375-66	7C375L-66
Maximum Propagation Delay, t_{PD} (ns)		12	15	20	20
Minimum Set-Up, t_S (ns)		6	8	10	10
Maximum Clock to Output, t_{CO} (ns)		7	8	10	10
Maximum Supply Current, I_{CC} (mA)	Commercial	330	300	300	150
	Military/Industrial		370	370	

Shaded area contains preliminary information.

Pin Configurations

TQFP/CQFP

Top View



Pin Configurations (continued)

PGA BottomView															
R	I/O ₁₀₉	I/O ₁₁₂	I/O ₁₁₅	I/O ₁₁₈	I/O ₁₂₁	I/O ₁₂₃	I/O ₁₂₆	I/O ₁₂₇	I/O ₀	I/O ₃	I/O ₅	I/O ₇	I/O ₁₀	I/O ₁₁	I/O ₁₄
P	I/O ₁₀₆	I/O ₁₁₀	I/O ₁₁₃	I/O ₁₁₆	I/O ₁₁₉	I/O ₁₂₂	I/O ₁₂₅	GND	I/O ₁	I/O ₄	I/O ₆	I/O ₉	I/O ₁₃	I/O ₁₅	I/O ₁₆
N	I/O ₁₀₅	I/O ₁₀₈	I/O ₁₁₁	I/O ₁₁₄	I/O ₁₁₇	I/O ₁₂₀	I/O ₁₂₄	I ₅	I/O ₂	GND	I/O ₈	I/O ₁₂	GND	I/O ₁₇	I/O ₁₉
M	I/O ₁₀₂	I/O ₁₀₄	I/O ₁₀₇	V _{CC}			V _{CC}	GND	V _{CC}			GND	I/O ₁₈	I/O ₂₀	I/O ₂₂
L	I/O ₁₀₀	I/O ₁₀₁	I/O ₁₀₃										I/O ₂₁	I/O ₂₃	I/O ₂₅
K	I/O ₉₈	I/O ₉₉	GND										I/O ₂₄	I/O ₂₆	I/O ₂₇
J	I/O ₉₆	I/O ₉₇	CLK3 /I ₄	V _{CC}								V _{CC}	I/O ₂₈	I/O ₂₉	I/O ₃₀
H	I/O ₉₅	GND	CLK2 /I ₃	GND								GND	CLK0 /I ₀	GND	I/O ₃₁
G	I/O ₉₄	I/O ₉₃	I/O ₉₂	V _{CC}								V _{CC}	CLK1 /I ₁	I/O ₃₃	I/O ₃₂
F	I/O ₉₁	I/O ₉₀	I/O ₈₈										GND	I/O ₃₅	I/O ₃₄
E	I/O ₈₉	I/O ₈₇	I/O ₈₅										I/O ₃₉	I/O ₃₇	I/O ₃₆
D	I/O ₈₆	I/O ₈₄	I/O ₈₂	GND			V _{CC}	GND	V _{CC}			V _{CC}	I/O ₄₃	I/O ₄₀	I/O ₃₈
C	I/O ₈₃	I/O ₈₁	GND	I/O ₇₆	I/O ₇₂	GND	I/O ₆₆	I ₂	I/O ₆₀	I/O ₅₆	I/O ₅₃	I/O ₅₀	I/O ₄₇	I/O ₄₄	I/O ₄₁
B	I/O ₈₀	I/O ₇₉	I/O ₇₇	I/O ₇₃	I/O ₇₀	I/O ₆₈	I/O ₆₅	GND	I/O ₆₁	I/O ₅₈	I/O ₅₅	I/O ₅₂	I/O ₄₉	I/O ₄₆	I/O ₄₂
A	I/O ₇₈	I/O ₇₅	I/O ₇₄	I/O ₇₁	I/O ₆₉	I/O ₆₇	I/O ₆₄	I/O ₆₃	I/O ₆₂	I/O ₅₉	I/O ₅₇	I/O ₅₄	I/O ₅₁	I/O ₄₈	I/O ₄₅
	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15

7C375-2

7C375-2

Functional Description (continued)

Logic Block

The number of logic blocks distinguishes the members of the FLASH370 family. The CY7C375 includes eight logic blocks. Each logic block is constructed of a product term array, a product term allocator, and 16 macrocells.

Product Term Array

The product term array in the FLASH370 logic block includes 36 inputs from the PIM and outputs 86 product terms to the product term allocator. The 36 inputs from the PIM are available in both positive and negative polarity, making the overall array size 72 x 86. This large array in each logic block allows for very complex functions to be implemented in single passes through the device.

Product Term Allocator

The product term allocator is a dynamic, configurable resource that shifts product terms to macrocells that require them. Any number of product terms between 0 and 16 inclusive can be assigned to any of the logic block macrocells (this is called product term steering). Furthermore, product terms can be shared among multiple macrocells. This means that product

terms that are common to more than one output can be implemented in a single product term. Product term steering and product term sharing help to increase the effective density of the FLASH370 PLDs. Note that product term allocation is handled by software and is invisible to the user.

I/O Macrocell

Each of the macrocells on the CY7C375 has a separate I/O pin associated with it. The input to the macrocell is the sum of between 0 and 16 product terms from the product term allocator. The macrocell includes a register that can be optionally bypassed, polarity control over the input sum-term, and four global clocks to trigger the register. The macrocell also features a separate feedback path to the PIM so that the register can be buried if the I/O pin is used as an input.

Programmable Interconnect Matrix

The Programmable Interconnect Matrix (PIM) connects the eight logic blocks on the CY7C375 to the inputs and to each other. All inputs (including feedbacks) travel through the PIM. There is no speed penalty incurred by signals traversing the PIM.

Development Tools

Development software for the CY7C375 is available from Cypress's *Warp2™* and *Warp3™* software packages. Both of these products are based on the IEEE standard VHDL language. Cypress also supports third-party vendors such as ABEL™, CUPL™, and LOG/IC™. Please refer to third-party tool support data sheets for further information.

Maximum Ratings

(Above which the useful life may be impaired. For user guidelines, not tested.)

Storage Temperature -65°C to +150°C

Ambient Temperature with

Power Applied..... -55°C to +125°C

Supply Voltage to Ground Potential -0.5V to +7.0V

DC Voltage Applied to Outputs

in High Z State -0.5V to +7.0V

DC Input Voltage -0.5V to +7.0V

DC Program Voltage 12.5V

Output Current into Outputs 16 mA

Static Discharge Voltage >2001V
(per MIL-STD-883, Method 3015)

Latch-Up Current..... >200 mA

Operating Range

Range	Ambient Temperature	V _{CC}
Commercial	0°C to +70°C	5V ± 5%
Industrial	-40°C to +85°C	5V ± 10%
Military ^[1]	-55°C to +125°C	5V ± 10%

Notes:

1. T_A is the "instant on" case temperature.

Electrical Characteristics Over the Operating Range^[2]

Parameter	Description	Test Conditions		Min.	Max.	Unit
V _{OH}	Output HIGH Voltage	V _{CC} = Min.	I _{OH} = -3.2 mA (Com'l/Ind)	2.4		V
			I _{OH} = -2.0 mA (Mil)			V
V _{OL}	Output LOW Voltage	V _{CC} = Min.	I _{OL} = 16 mA (Com'l/Ind)		0.5	V
			I _{OL} = 12 mA (Mil)			V
V _{IH}	Input HIGH Voltage	Guaranteed Input Logical HIGH voltage for all inputs ^[3]		2.0	7.0	V
V _{IL}	Input LOW Voltage	Guaranteed Input Logical LOW voltage for all inputs ^[3]		-0.5	0.8	V
I _{IX}	Input Load Current	V _I = Internal GND, V _I = V _{CC}		-10	+10	μA
I _{OZ}	Output Leakage Current	V _O = Internal GND, V _O = V _{CC}		-50	+50	μA
I _{OS}	Output Short Circuit Current ^[4, 5]	V _{CC} = Max., V _{OUT} = 0.5V		-30	-160	mA
I _{CC}	Power Supply Current ^[6]	V _{CC} = Max., I _{OUT} = 0 mA, f = 1 MHz, V _{IN} = GND, V _{CC}	Com'l		330	mA
			Com'l "L" -66		150	mA
			Mil/Ind		370	mA

Shaded area contains preliminary information.

Capacitance^[5]

Parameter	Description	Test Conditions	Max.	Unit
C _{IN}	Input Capacitance	V _{IN} = 5.0V at f = 1 MHz	10	pF
C _{OUT}	Output Capacitance	V _{OUT} = 5.0V at f = 1 MHz	12	pF

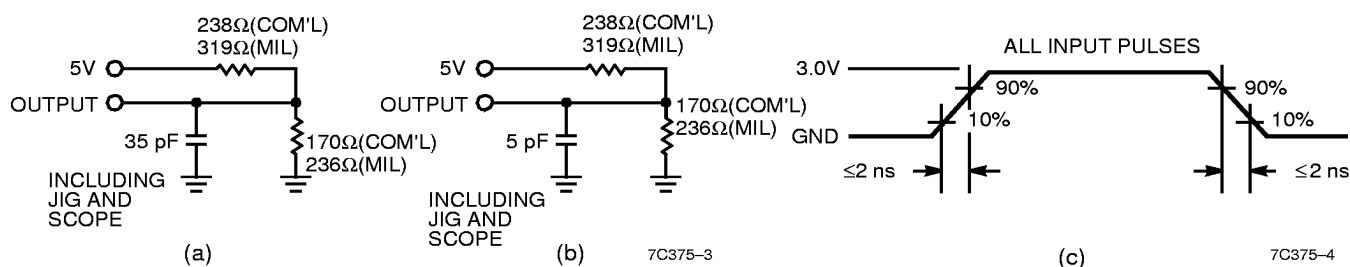
Endurance Characteristics^[5]

Parameter	Description	Test Conditions	Min.	Max.	Unit
N	Minimum Reprogramming Cycles	Normal Programming Conditions	100		Cycles

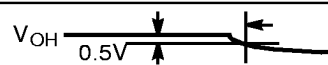
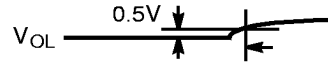
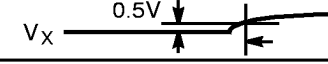

Notes:

2. See the last page of this specification for Group A subgroup testing information.
3. These are absolute values with respect to device ground. All overshoots due to system or tester noise are included.
4. Not more than one output should be tested at a time. Duration of the short circuit should not exceed 1 second. V_{OUT} = 0.5V has been chosen to avoid test problems caused by tester ground degradation.
5. Tested initially and after any design or process changes that may affect these parameters.
6. Measured with 16-bit counter programmed into each logic block.

AC Test Loads and Waveforms



Equivalent to: THEVENINEQUIVALENT
 99Ω (COM'L)
 136Ω (MIL) 2.08V (COM'L)
 2.13V (MIL)

Parameter ^[7]	V _X	Output Waveform Measurement Level
t _{ER} (-)	1.5V	
t _{ER} (+)	2.6V	
t _{EA} (+)	1.5V	
t _{EA} (-)	V _{thc}	

(d) Test Waveforms

Switching Characteristics Over the Operating Range^[8]

Parameter	Description	7C375-100		7C375-83		7C375-66		Unit
		Min.	Max.	Min.	Max.	7C375L-66		
						Min.	Max.	
Combinatorial Mode Parameters								
t _{PD}	Input to Combinatorial Output		12		15		20	ns
t _{PDL}	Input to Output Through Transparent Input or Output Latch		15		18		22	ns
t _{PDLL}	Input to Output Through Transparent Input and Output Latches		16		19		24	ns
t _{EA}	Input to Output Enable		16		19		24	ns
t _{ER}	Input to Output Disable		16		19		24	ns
Input Registered/Latched Mode Parameters								
t _{WL}	Clock or Latch Enable Input LOW Time ^[5]	3		4		5		ns
t _{WH}	Clock or Latch Enable Input HIGH Time ^[5]	3		4		5		ns
t _{IS}	Input Register or Latch Set-Up Time	2		3		4		ns
t _{IH}	Input Register or Latch Hold Time	2		3		4		ns
t _{ICO}	Input Register Clock or Latch Enable to Combinatorial Output		16		19		24	ns
t _{ICOL}	Input Register Clock or Latch Enable to Output Through Transparent Output Latch		18		21		26	ns

Shaded area contains preliminary information.

Notes:

- t_{ER} measured with 5-pF AC Test Load and t_{EA} measured with 35-pF AC Test Load.
- All AC parameters are measured with 16 outputs switching and 35-pF AC Test Load.

Switching Characteristics Over the Operating Range^[8]

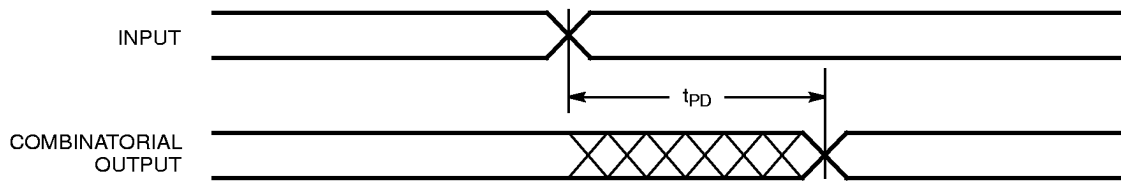
Parameter	Description	7C375-100		7C375-83		7C375-66		Unit
		7C375-100		7C375-83		7C375L-66		
		Min.	Max.	Min.	Max.	Min.	Max.	
Output Registered/Latched Mode Parameters								
t _{CO}	Clock or Latch Enable to Output		7		8		10	ns
t _S	Set-Up Time from Input to Clock or Latch Enable	6		8		10		ns
t _H	Register or Latch Data Hold Time	0		0		0		ns
t _{CO2}	Output Clock or Latch Enable to Output Delay (Through Memory Array)		16		19		24	ns
t _{SCS}	Output Clock or Latch Enable to Output Clock or Latch Enable (Through Memory Array)	10		12		15		ns
t _{SL}	Set-Up Time from Input Through Transparent Latch to Output Register Clock or Latch Enable	12		15		20		ns
t _{HL}	Hold Time for Input Through Transparent Latch from Output Register Clock or Latch Enable	0		0		0		ns
f _{MAX1}	Maximum Frequency with Internal Feedback (Least of 1/t _{SCS} , 1/(t _S + t _H), or 1/t _{CO}) ^[5]	100		83		66		MHz
f _{MAX2}	Maximum Frequency Data Path in Output Registered/Latched Mode (Lesser of 1/(t _{WL} + t _{WH}), 1/(t _S + t _H), or 1/t _{CO})	143		125		100		MHz
f _{MAX3}	Maximum Frequency with External Feedback (Lesser of 1/(t _{CO} + t _S) and 1/(t _{WL} + t _{WH}))	76.9		62.5		50		MHz
t _{OH} -t _{IH} 37x	Output Data Stable from Output clock Minus Input Register Hold Time for 7C37x ^[5, 9]	0		0		0		ns
Pipelined Mode Parameters								
t _{ICS}	Input Register Clock to Output Register Clock	10		12		15		ns
f _{MAX4}	Maximum Frequency in Pipelined Mode (Least of 1/(t _{CO} + t _{IS}), 1/t _{ICS} , 1/(t _{WL} + t _{WH}), 1/(t _{IS} + t _{IH}), or 1/t _{SCS})	100		83.3		66.6		MHz
Reset/Preset Parameters								
t _{RW}	Asynchronous Reset Width ^[5]	12		15		20		ns
t _{RR}	Asynchronous Reset Recovery Time ^[5]	14		17		22		ns
t _{RO}	Asynchronous Reset to Output		18		21		26	ns
t _{PW}	Asynchronous Preset Width ^[5]	12		15		20		ns
t _{PR}	Asynchronous Preset Recovery Time ^[5]	14		17		22		ns
t _{PO}	Asynchronous Preset to Output		18		21		26	ns
t _{POR}	Power-On Reset		1		1		1	μs

Notes:

9. This specification is intended to guarantee interface compatibility of the other members of the CY7C370 family with the CY7C375. This specification is met for the devices operating at the same ambient temperature and at the same power supply voltage.

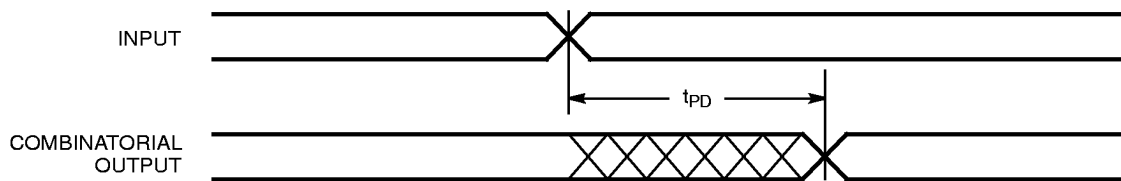
Switching Waveforms

CombinatorialOutput



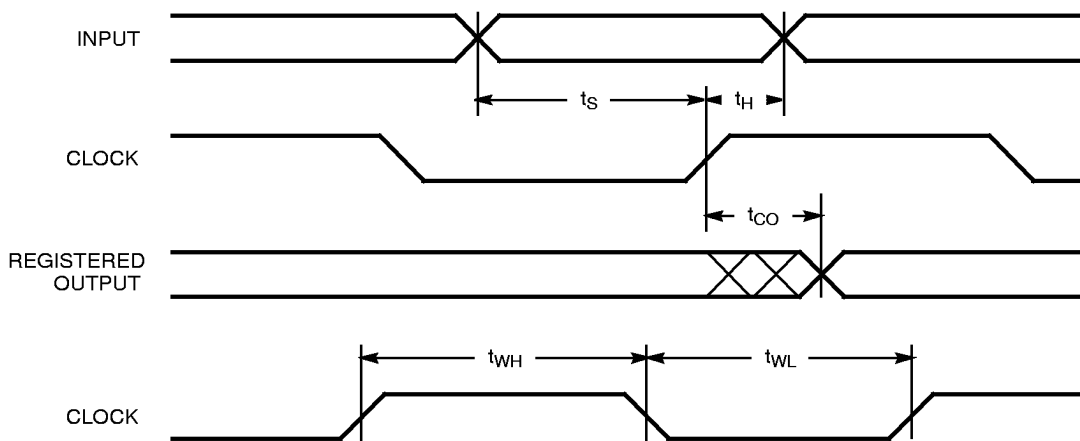
7C375-5

CombinatorialOutput



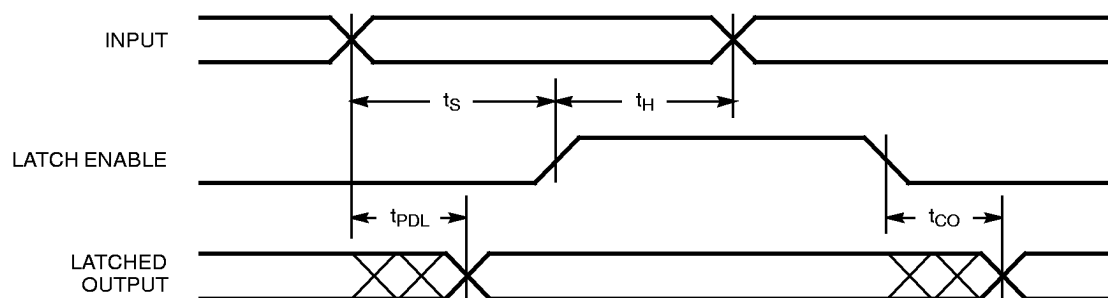
7C375-6

RegisteredOutput

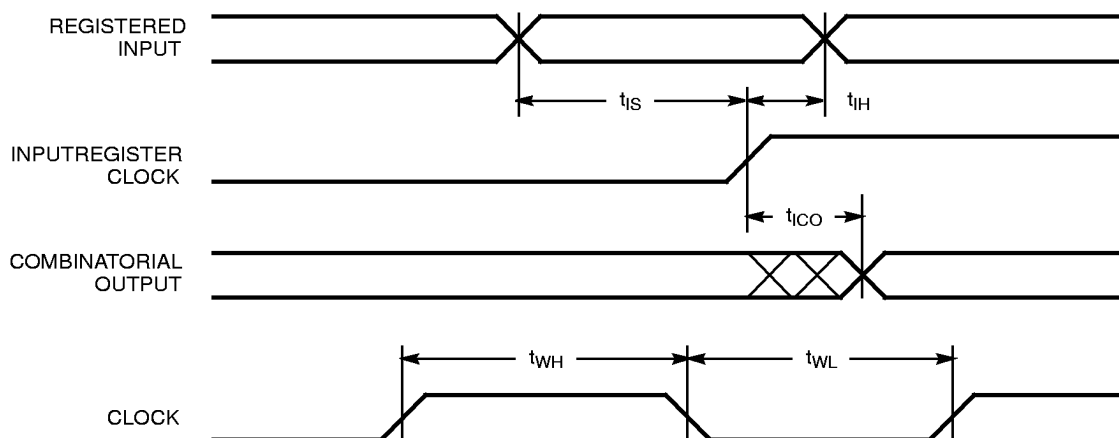
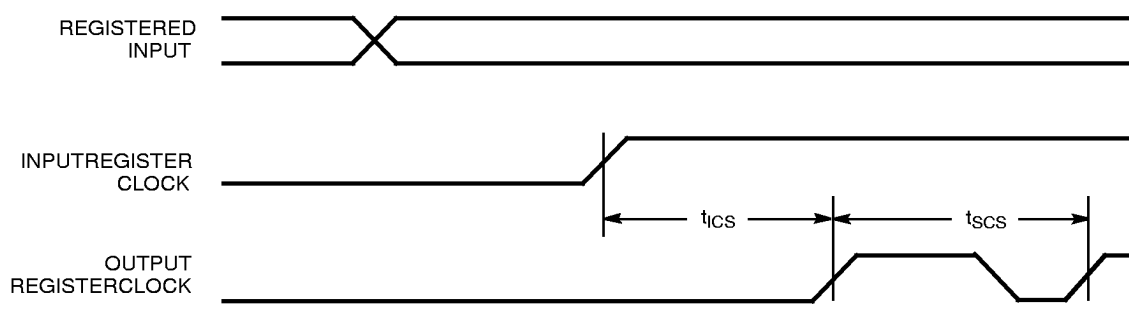
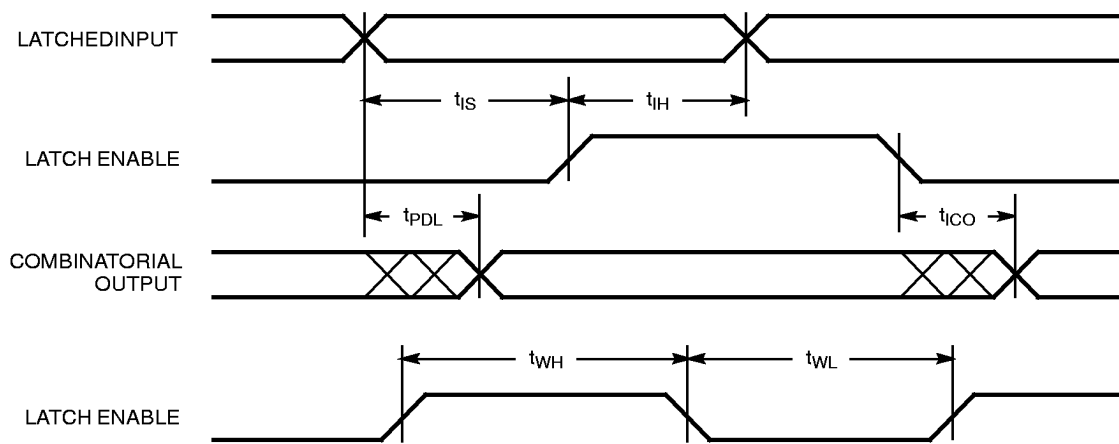


7C375-7

Latched Output

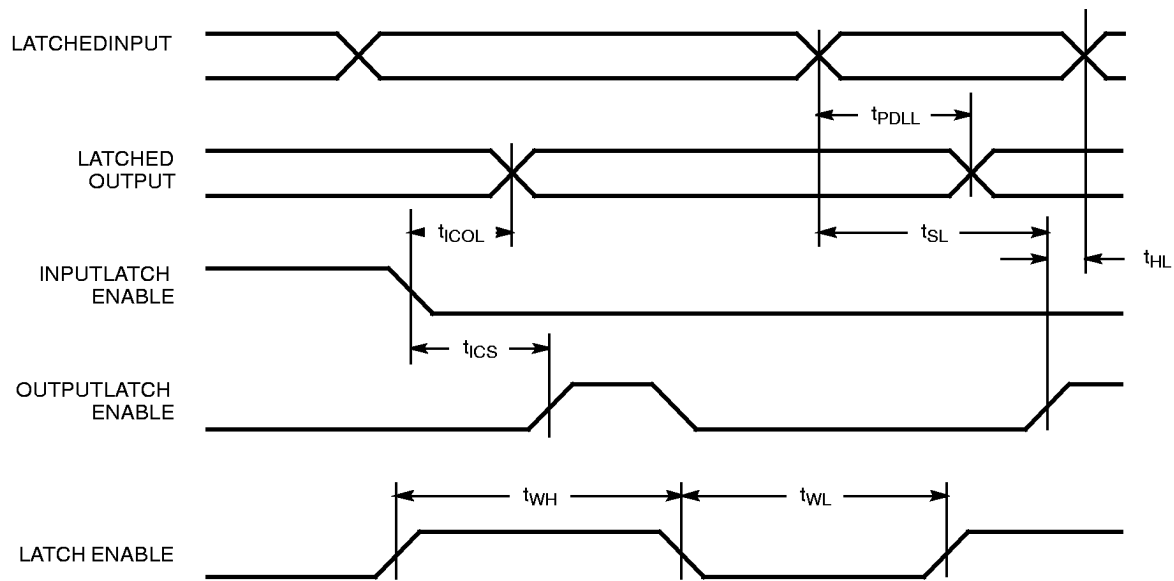


7C375-8

Switching Waveforms (continued)
Registered Input

Clock to Clock

Latched Input


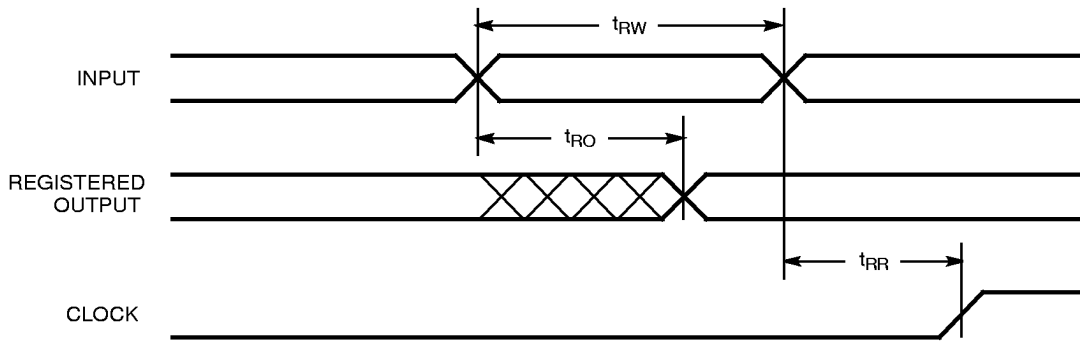
Switching Waveforms (continued)

Latched Input and Output



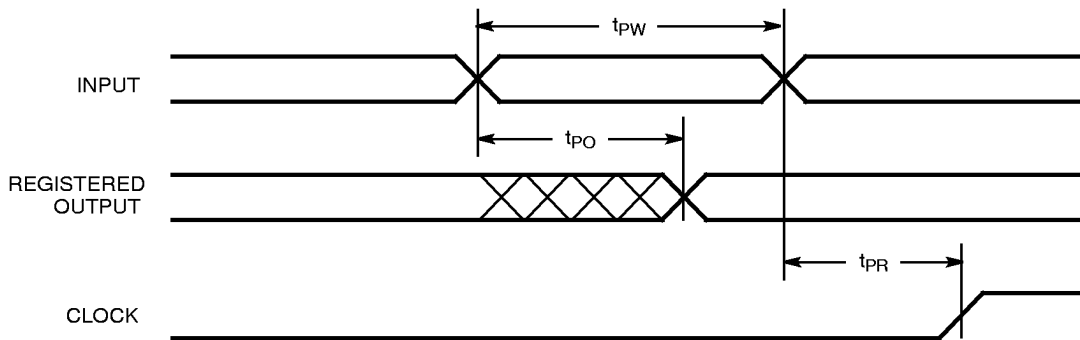
7C375-12

Asynchronous Reset

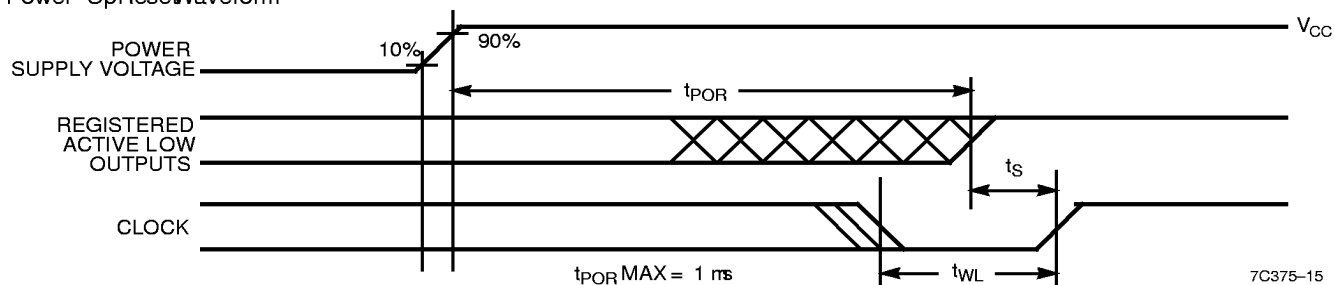
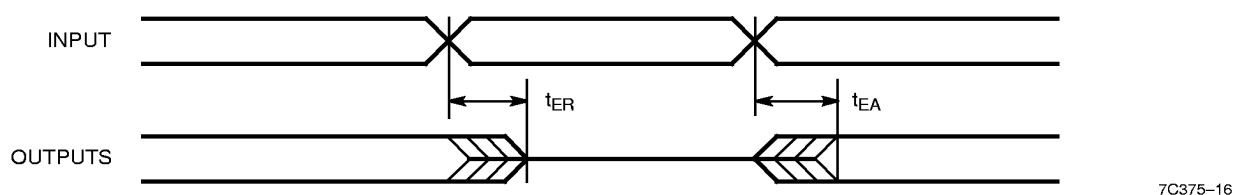


7C375-13

Asynchronous Preset



7C375-14

Switching Waveforms (continued)
Power-Up/Reset Waveform

Output Enable/Disable

Ordering Information

Speed (MHz)	Ordering Code	Package Name	Package Type	Operating Range
100	CY7C375-100AC	A160	160-Lead Thin Quad Flatpack	Commercial
83	CY7C375-83AC	A160	160-Lead Thin Quad Flatpack	Commercial
	CY7C375-83AI	A160	160-Lead Thin Quad Flatpack	Industrial
	CY7C375-83GMB	G160	160-Pin Grid Array	Military
	CY7C375-83UMB	U162	160-Pin Ceramic Quad Flatpack ^[10]	
66	CY7C375-66AC	A160	160-Lead Thin Quad Flatpack	Commercial
	CY7C375-66AI	A160	160-Lead Thin Quad Flatpack	Industrial
	CY7C375-66GMB	G160	160-Pin Grid Array	Military
	CY7C375-66UMB	U162	160-Pin Ceramic Quad Flatpack ^[10]	
66	CY7C375L-66AC	A160	160-Lead Thin Quad Flatpack	Commercial

Notes:

10. Available as custom trim and form version. Contact local Cypress office for package information.

MILITARY SPECIFICATIONS

Group A Subgroup Testing

DC Characteristics

Parameter	Subgroups
V_{OH}	1, 2, 3
V_{OL}	1, 2, 3
V_{IH}	1, 2, 3
V_{IL}	1, 2, 3
I_{IX}	1, 2, 3
I_{OZ}	1, 2, 3
I_{CC}	1, 2, 3

Switching Characteristics

Parameter	Subgroups
t_{PD}	9, 10, 11
t_{CO}	9, 10, 11
t_{ICO}	9, 10, 11
t_S	9, 10, 11
t_H	9, 10, 11
t_{IS}	9, 10, 11
t_{IH}	9, 10, 11
t_{ICS}	9, 10, 11

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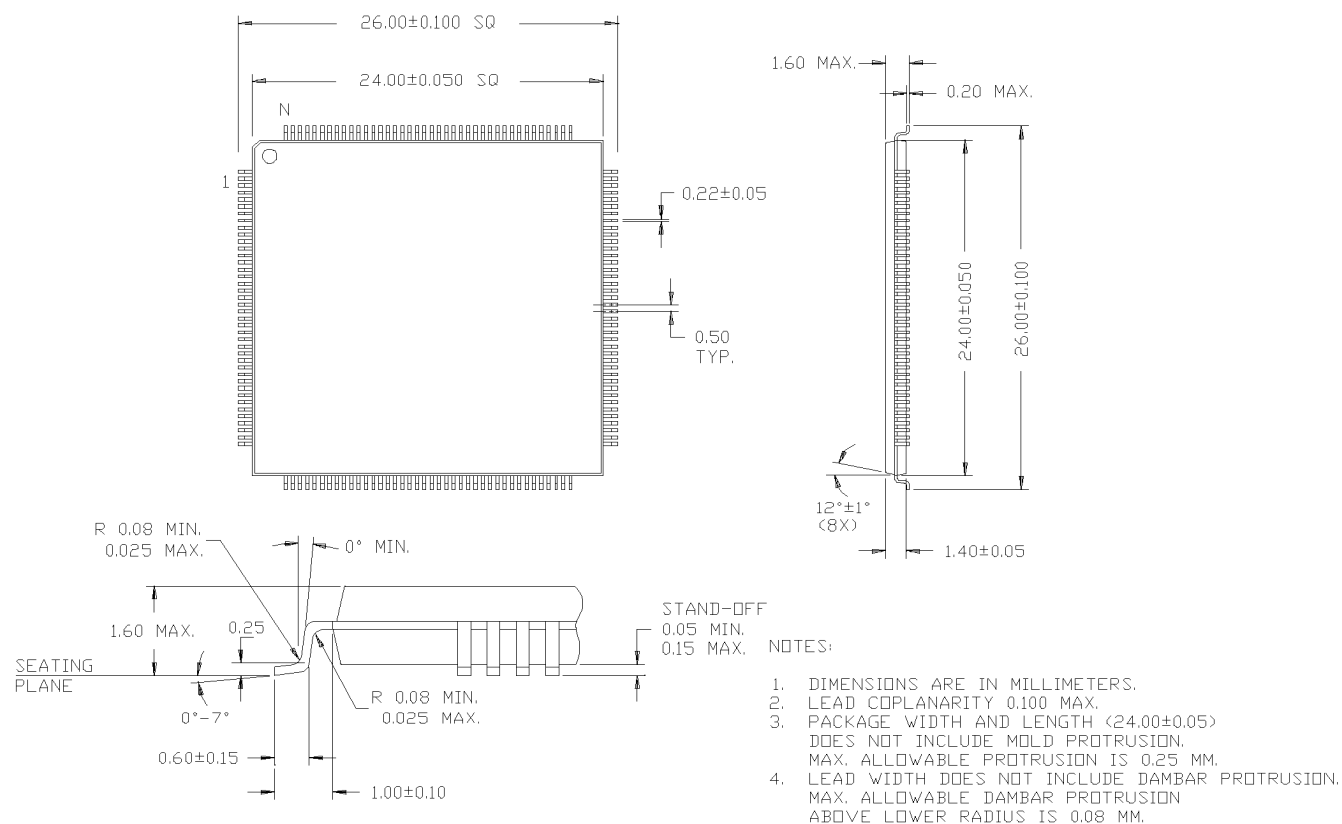
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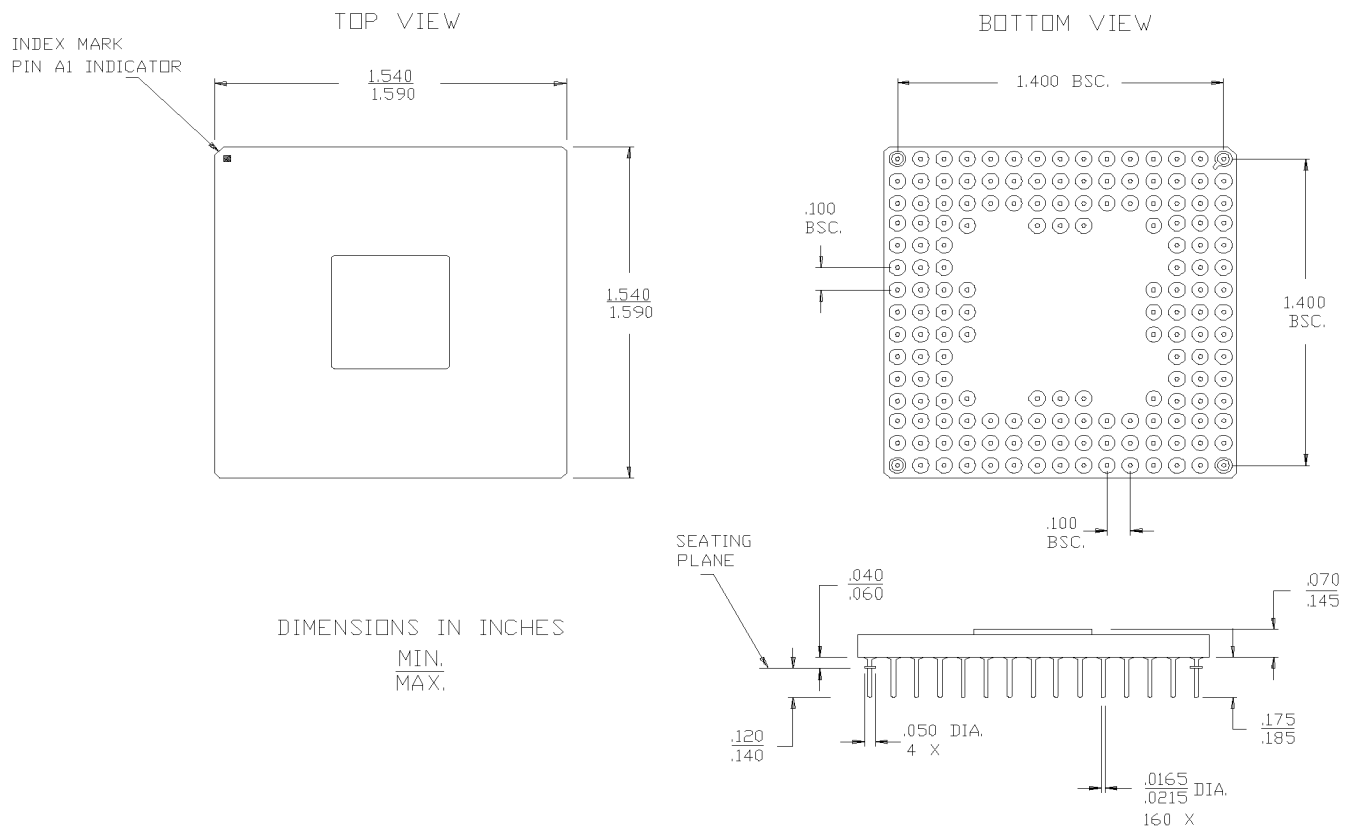
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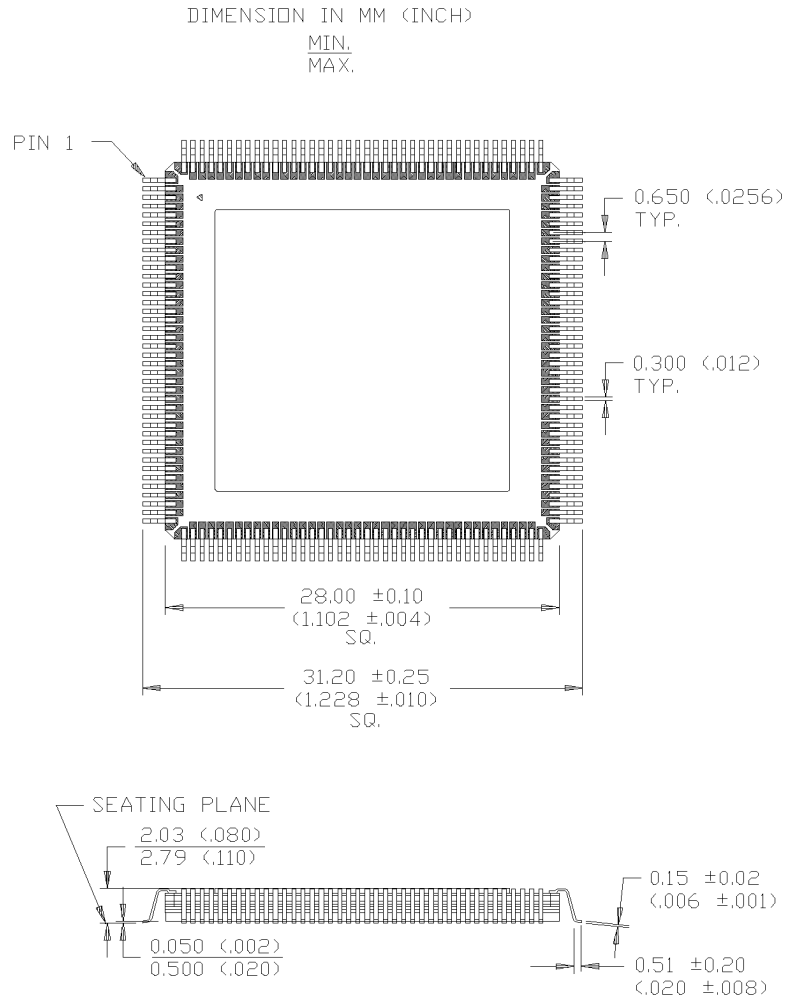
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Package Diagrams

160-Lead Thin Quad Flat Pack (TQFP) A160



Package Diagrams (continued)
160-Pin PGA G160


Package Diagrams (continued)
160-Lead Ceramic Quad Flatpack (Cavity Up) U162


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